IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)
• •	: Examiner: J. Waks
Nobushige KORENAGA)
Application No.: 10/735,650)	: Group Art Unit: 2834
Application No.: 10/755,050)	: Confirmation No.: 3534
Filed: December 16, 2003)
	: Allowed: August 1, 2005
For: ALIGNMENT APPARATUS AND EXPOSURE)
APPARATUS USING THE SAME	· August 17 2005

Mail Stop Issue Fee

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

LETTER REQUESTING CONSIDERATION OF PAPERS TIMELY FILED

Sir:

Applicant has received a Notice of Allowance and a Notice of Allowability dated August 1, 2005, in the above-identified application. However, in reviewing the Notice of Allowability, Applicant notes that the Examiner has not yet acknowledged receipt of the Submission of Priority Documents and the certified copies of the priority documents that were filed in the U.S. Patent and Trademark Office on February 12, 2004, submitting the certified copies of Japanese patent document numbers 2002-382495, filed December 27, 2002, and 2003-123832, filed April 28, 2003. For the Examiner's convenience, attached are copies of (1) the Submission of Priority Documents, (2) the cover page and drawings of the priority documents

(the only portions retained) and (3) the date stamped post card receipt indicating that these papers were received by the U.S. Patent and Trademark Office on February 12, 2004.

Applicant requests that the Examiner acknowledge receipt of the certified copies of the priority documents.

Applicant believes that no fees should be incurred in connection with filing this paper. However, the Commissioner is authorized to charge Deposit Account No. 06-1205, should any fees be associated herewith.

Applicant's undersigned attorney may be reached in our Washington, D.C. office by telephone at (202) 530-1010. All correspondence should be directed to our address listed below.

Respectfully submitted,

Attorney for Applicant

Scott D. Malpede

Registration No. 32,533

FITZPATRICK, CELLA, HARPER & SCINTO 30 Rockefeller Plaza
New York, New York 10112-3801
Facsimile: (212) 218-2200

SDM /eab

DC_MAIN 212797v1



		Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 Date 2 12 205 Mo. Day Yr. Atty. Docker 2 0 3385
	FCHS-D-00	Sir: Kindly acknowledge receipt of the accompanying: Response to Official Action. Check for \$
20 Sept. 18		Atty. SEUJEOB Due Date



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)
	: Examiner: Unassigned
Nobushige KORENAGA)
	: Group Art Unit: Unassigned
Application No.: 10/735,650)
	:
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	:
For: ALIGNMENT APPARATUS AND EXPOSURE) February 12, 2004
APPARATUS USING THE SAME	:

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUBMISSION OF PRIORITY DOCUMENTS

Sir:

In support of Applicant's claim for priority under 35 U.S.C. § 119, enclosed are two certified copies of the following foreign applications:

JAPAN

2002-382495, filed December 27, 2002; and

JAPAN

2003-123832, filed April 28, 2003.

Applicant's undersigned attorney may be reached in our Washington, D.C., office by telephone at (202) 530-1010. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Attorney for Applicant

Steven E. Warner

Registration No. 33,326

FITZPATRICK, CELLA, HARPER & SCINTO 30 Rockefeller Plaza
New York, New York 10112-3801
Facsimile: (212) 218-2200

SEW/eab

日本国特許庁 JAPAN PATENT OFFICE

別紙添付の書類に記載されている事項は下記の出願書類に記載されている事項と同一であることを証明する。

This is to certify that the annexed is a true copy of the following application as filed ith this Office.

出願年月日 Date of Application: 2002年12月27日

出願番号 pplication Number: 特願2002-382495

ST. 10/C]:

[JP2002-382495]

願 人 plicant(s): キヤノン株式会社

CERTIFIED COPY OF PRIORITY DOCUMENT

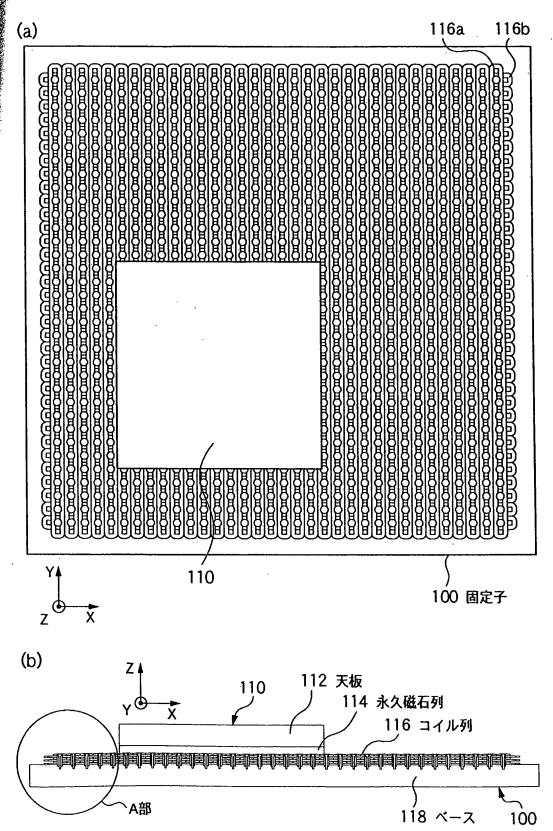
特許庁長官 Commissioner, Japan Patent Office 2004年 1月14日

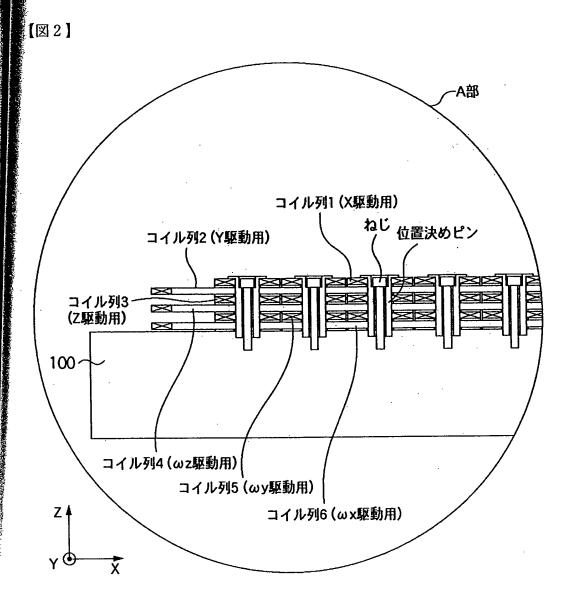




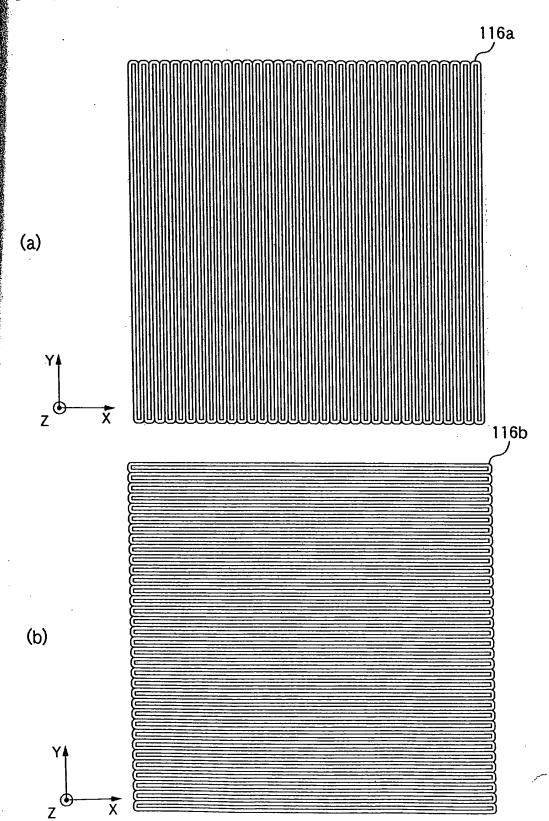
図面

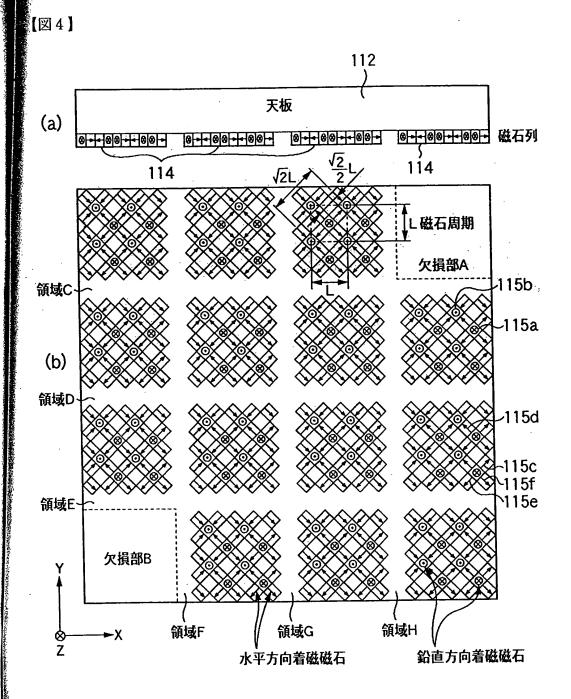






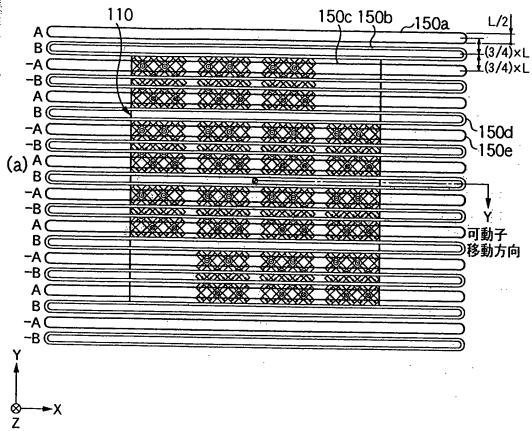
【図3】

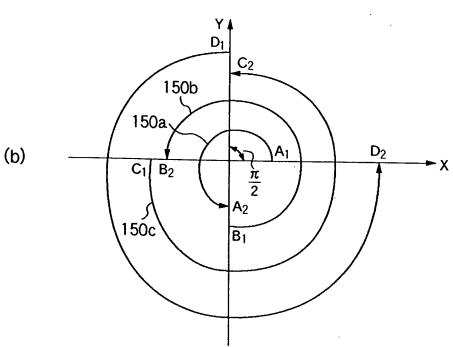


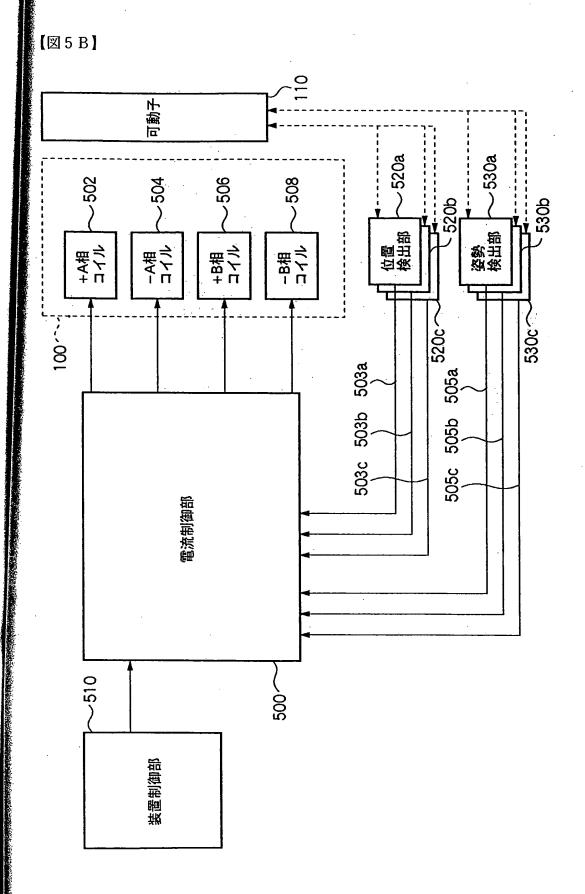




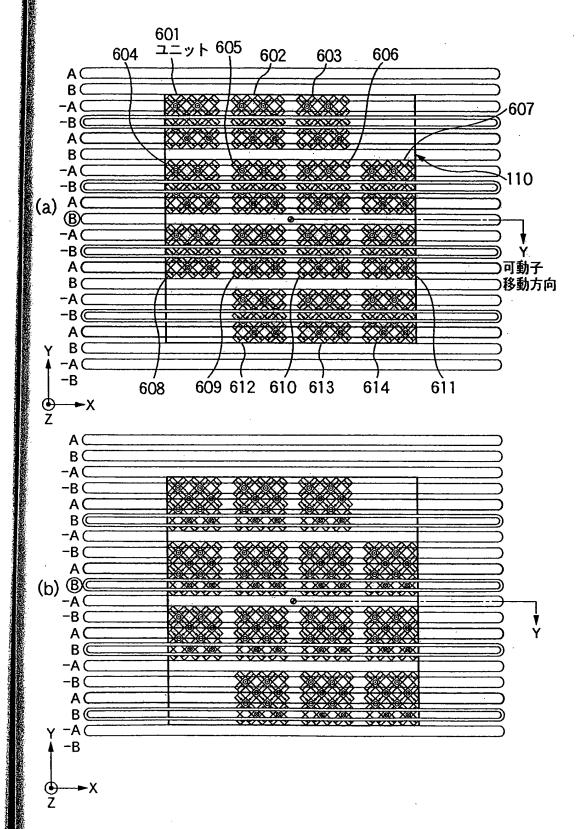
6.

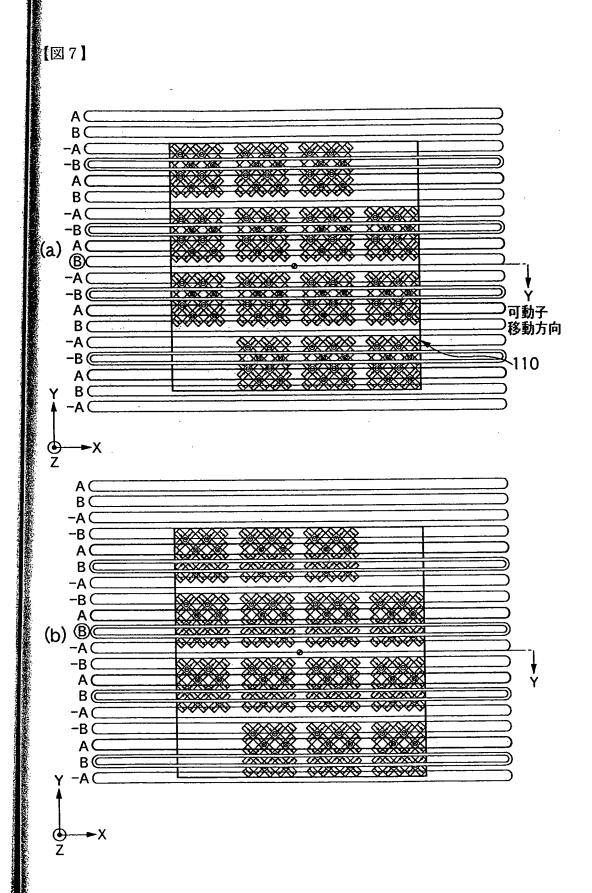


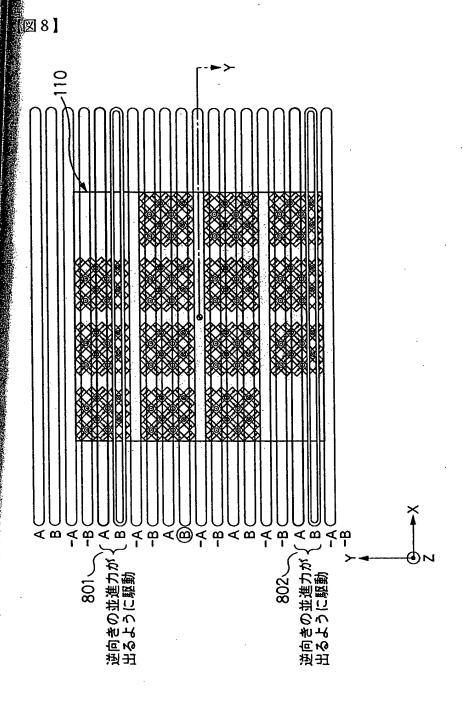




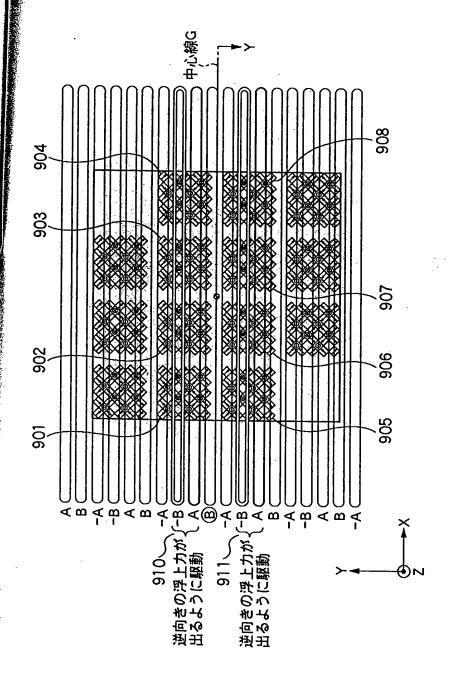


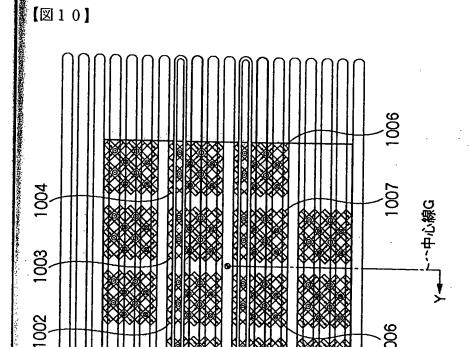




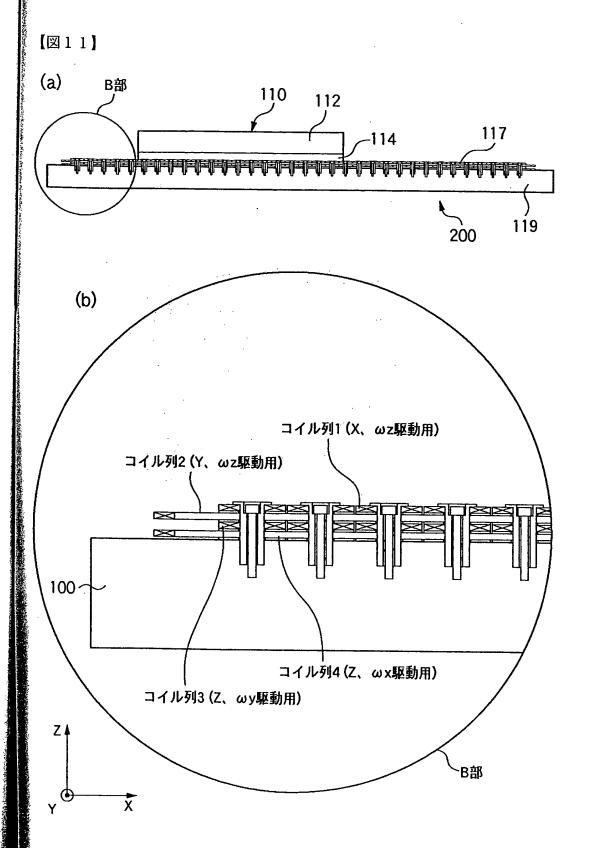


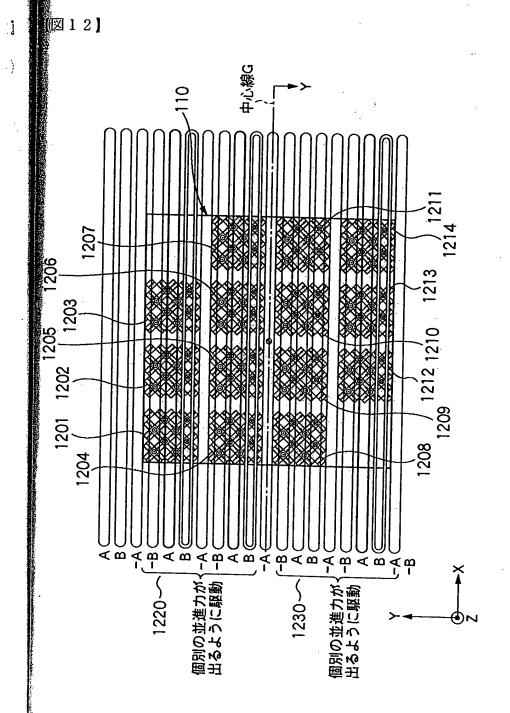




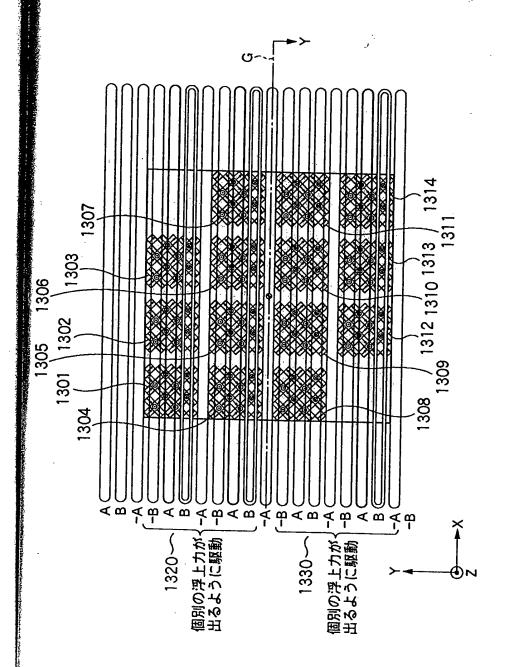


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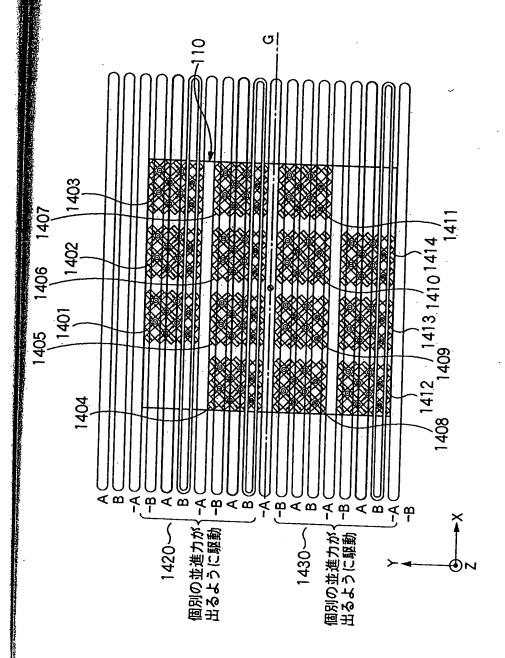
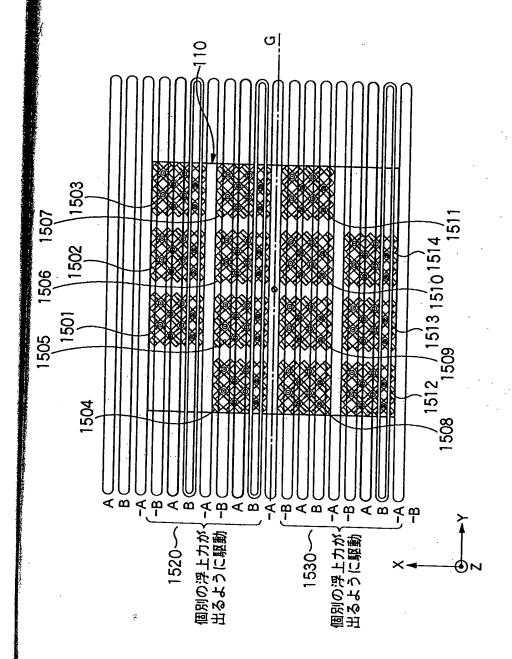
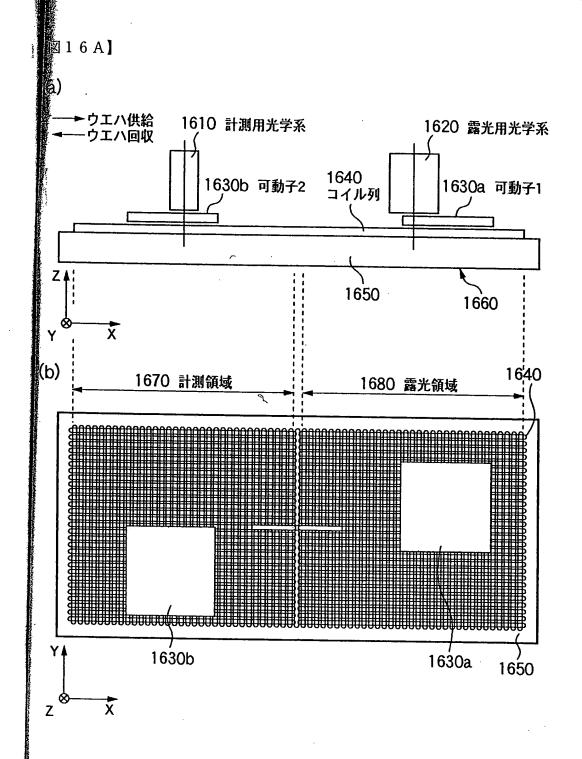
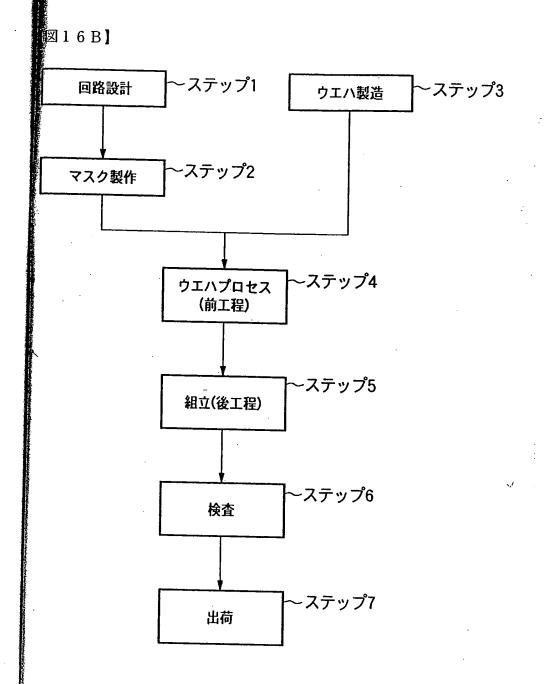


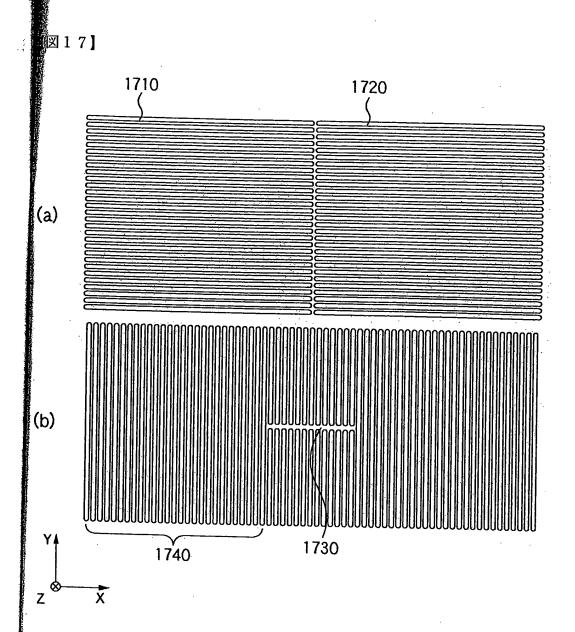
図15]

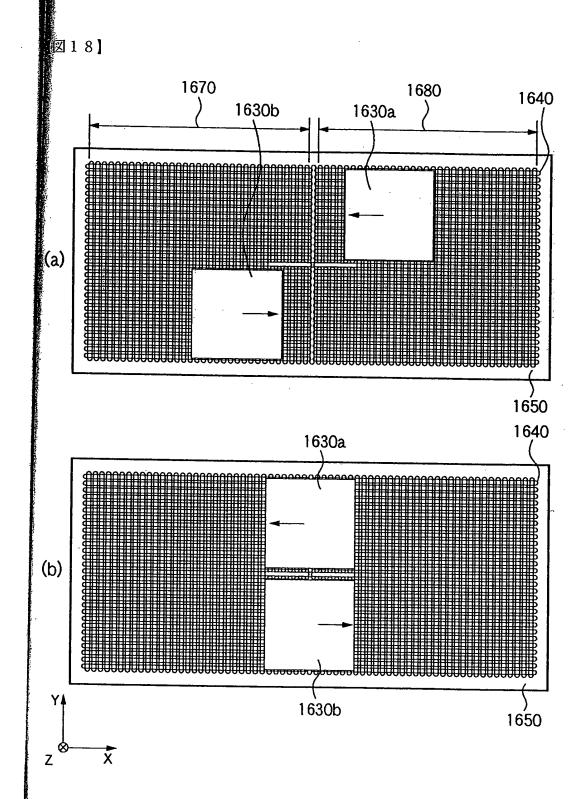


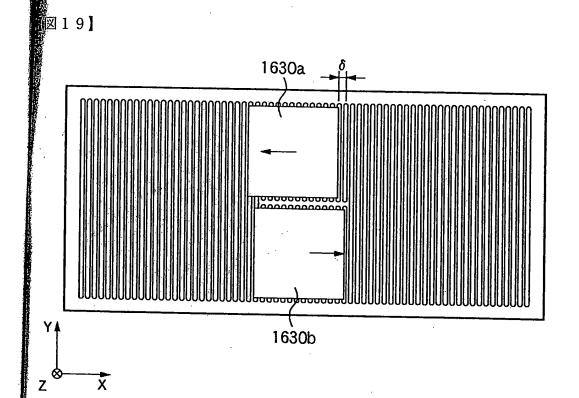


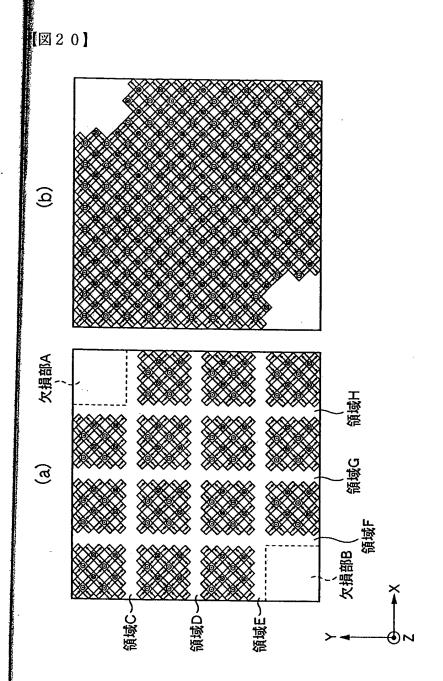


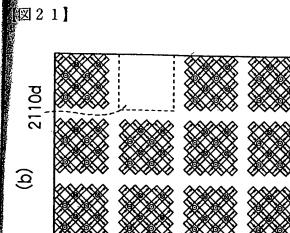
半導体デバイス製造フロー

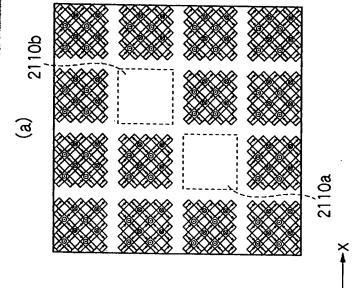


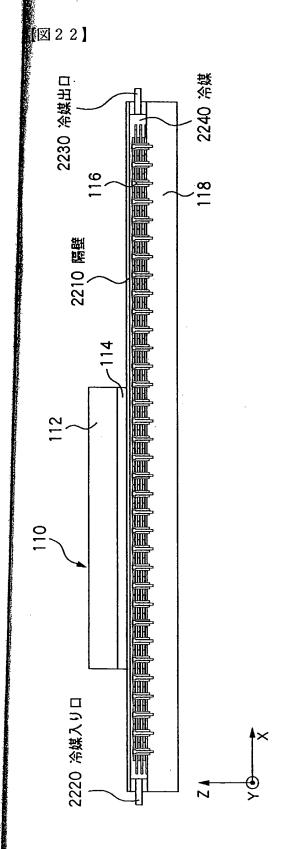


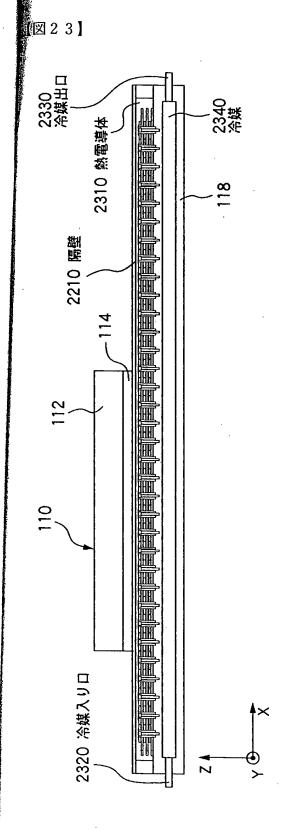




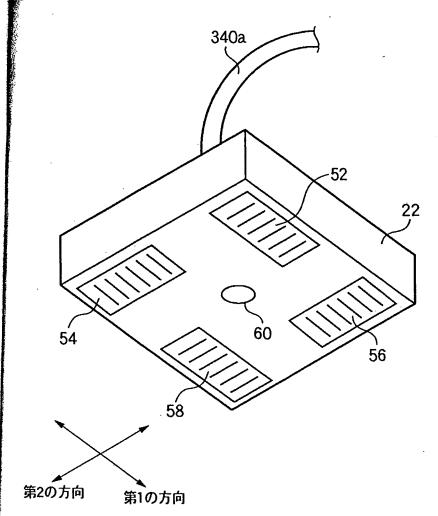




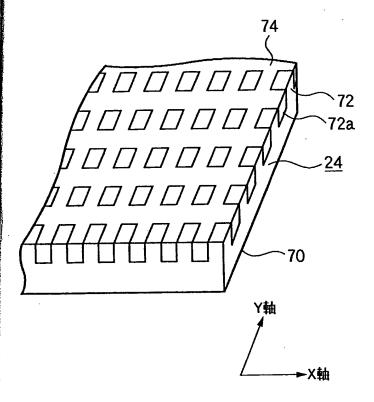




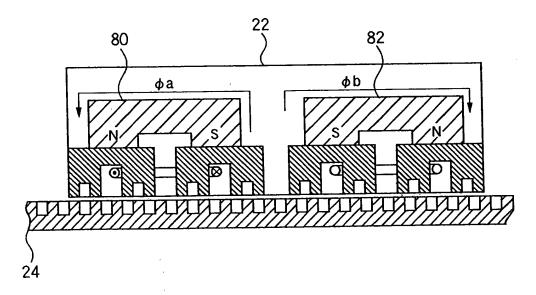




【図25】



[図26]



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